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EMC Test Report

Application No. : HX1711152443

Applicant: Shenzhen Red Star Electronics Co., Ltd.

Equipment Under Test (EUT)

EUT Name : USB Lanyard Cable

Model No. : RXD-888

Serial No. : See Page 3

Brand Name : N/A

Receipt Date : 2017-11-15

Test Date : 2017-11-15 to 2017-11-21

Issue Date : 2017-11-21

Standards : EN 55032: 2015

EN 55024: 2010 + A1: 2015

Conclusions : PASS

In the configuration tested, the EUT complied with the standards specified above The EUT technically complies with the 2014/30/EU directive requirements

Test/Witness Engineer

Approved & Authorized

FINAL S

This report details the results of the testing parried out on one sample. The results contained in this test report do not relate to other samples of the same product. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in the report.



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1. General Information

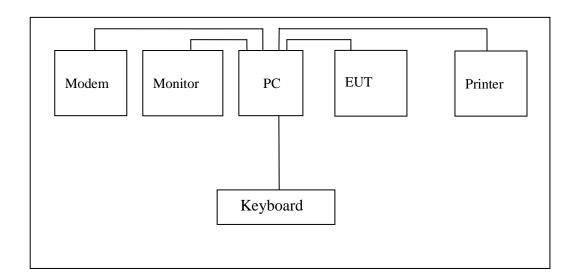
1.1. Client Information

Applicant	:	Shenzhen Red Star Electronics Co., Ltd.	
Address	:	Jin Yu Alley 1-8, SiFangPu Community, PingDi Street, Longgang District, Shenzhen City, GuangDong, China	
Manufacturer : Shenzhen Red Star Electronics Co., Ltd.		Shenzhen Red Star Electronics Co., Ltd.	
Address	:	Jin Yu Alley 1-8, SiFangPu Community, PingDi Street, Longgang District, Shenzhen City, GuangDong, China	

1.2. General Description of EUT (Equipment Under Test)

EUT Name		USB Lanyard Cable			
Model No.	•	RXD-888			
Serial No.		N/A			
Brand Name		N/A			
Power Supply	:	DC 5.0V			

1.3. Block Diagram Showing The Configuration of System Tested





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1.4. Description of Support Units

Name	Model	S/N	Manufacturer	Used "√"
Printer	HP1505n	VNF3G06957	HP	√
Modem	RX304Xv2		ASUS	√
LCD Monitor	E170Sc		DELL	√
PC	OPTIPLEX380		DELL	√
Keyboard	L100	U01C	DELL	√

1.5. Performance Criterion

Criterion A: The equipment shall continue to operate as intended without operator intervention. No degradation of performance of loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

Criterion B: After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.

Criterion C: Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.

1.6. Test Facility

The testing report were performed by the Shenzhen HX Certification Testing Technology Co., Ltd., in their facilities located at 8/F, Haoyunlai Building B, Baomin 2th Road, Xixiang Street, Baoan District, Shenzhen, China.



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2. TEST Results Summary

EMISSION					
Description of test items	Standards	Results			
Conducted disturbance at mains terminals	EN 55032: 2015	N/A			
Radiated Disturbance	EN 55032: 2015	Pass			
Harmonic current emissions	EN 61000-3-2: 2014	N/A			
Voltage fluctuation and flicker	EN 61000-3-3: 2013	N/A			
IMMUNITY					
Description of test items	Standards	Results			
Electrostatic Discharge (ESD)	EN 61000-4-2: 2009	Pass			
Radio-frequency, Continuous radiated disturbance	EN 61000-4-3: 2006+A1:2008+A2:2010	Pass			
EFT/B Immunity	EN 61000-4-4: 2012	N/A			
Surge Immunity	EN 61000-4-5: 2014	N/A			
Conducted RF Immunity	EN 61000-4-6: 2014	N/A			
Power frequency magnetic field	EN 61000-4-8: 2010	N/A			
Voltage dips, >95% reduction					
Voltage dips, 30% reduction	EN 61000-4-11: 2004	N/A			
Voltage interruptions					
Note: N/A is an abbreviation for Not Applicable.					



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3. Test Equipment Used

3.1. Test Eq	uipment Used to	Measure Conduc	ted Emission	1			
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval		
HX-EMC001	EMI Test Receiver	Rohde & Schwarz	ESCS30	Jan.04, 2017	1 Year		
HX-EMC002	AMN	Rohde & Schwarz	ENV216	Jan.04, 2017	1 Year		
HX-EMC003	AMN	SCHWARZBECK	NNBL 8226	Jan.04, 2017	1 Year		
3.2. Test Equipment Used to Measure Radiated Emission							
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval		
HX-EMC004	EMI Test Receiver	Rohde & Schwarz	ESI26	Jan.04, 2017	1 Year		
HX-EMC005	Bilog Antenna	SCHWARZBECK	VULB9163	Jan.04, 2017	1 Year		
HX-EMC006	Positioning Controller	C&C	CC-C-1F	N/A	N/A		
3.3. Test Eq Flicker	uipment Used to	Measure Harmon	ic Current/ V	oltage Fluctua	tion and		
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval		
HX-EMC007	Harmonic Flicker Test System	CI	5001ix-CTS- 400	Jan.04, 2017	1 Year		
3.4. Test Eq	uipment Used to	Measure Electros	static Dischar	ge Immunity			
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval		
HX-EMC008	ESD Tester	TESEQ	NSG437	Jan.04, 2017	1 Year		
3.5. Test Eq	uipment Used to	Measure Conduc	ted Immunity	1			
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval		
HX-EMC009	RF Generator	FRANKONIA	CIT-10/75	Jan.04, 2017	1 Year		
HX-EMC010	Attenuator	FRANKONIA	59-6-33	Jan.04, 2017	1 Year		
HX-EMC011	M-CDN	LUTHI	M2/M3	Jan.04, 2017	1 Year		
HX-EMC012	CDN	LUTHI	AF2	Jan.04, 2017	1 Year		
HX-EMC013	EM Injection Clamp	LUTHI	EM101	Jan.04, 2017	1 Year		
3.6. Test E Immunity	Equipment Used	to Measure Rac	dio Frequenc	y Electroma	gnetic Fields		
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval		
HX-EMC014	Signal Generator	Rohde & Schwarz	SMT03	Jan.04, 2017	1 Year		



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HX-EMC015	Power Meter	Rohde & Schwarz	NRVD	Jan.04, 2017	1 Year		
HX-EMC016	Voltage Probe	Rohde & Schwarz	URV5-Z2	Jan.04, 2017	1 Year		
HX-EMC017	Voltage Probe	Rohde & Schwarz	URV5-Z2	Jan.04, 2017	1 Year		
HX-EMC018	Power Amplifier	AR	150W1000	Jan.04, 2017	1 Year		
HX-EMC019	Bilog Antenna	Chase	CBL6111C	Jan.04, 2017	1 Year		
3.7. Test Eq	uipment Used to I	Measure Electrica	l Fast Transi	ent/Burst Imm	nunity		
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval		
HX-EMC020	Simulator	EMTEST	UCS500N5	Jan.04, 2017	1 Year		
HX-EMC021	Auto-transformer	EMTEST	V4780S2	Jan.04, 2017	1 Year		
3.8. Test Eq	uipment Used to I	Measure Surge Im	munity				
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval		
HX-EMC022	Simulator	EMTEST	UCS500N5	Jan.04, 2017	1 Year		
HX-EMC023	Coupling Clamp	EMTEST	HFK	Jan.04, 2017	1 Year		
3.9. Test Eq	uipment Used to I	Measure Voltage I	Dips and Inte	erruptions Imn	nunity		
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval		
HX-EMC022	Simulator	EMTEST	UCS500N5	Jan.04, 2017	1 Year		
HX-EMC023	Coupling Clamp	EMTEST	HFK	Jan.04, 2017	1 Year		
3.10. Test E	3.10. Test Equipment Used to Measure Power frequency Magnetic Field						
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval		
HX-EMC026	Power Frequency Magnetic Field Generator	EVERFINE	EMS61000-8	Jan.04, 2017	1 Year		



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4. Radiated Emission Test

4.1. Test Standard and Limit

4.1.1. Test Standard

EN 55032: 2015

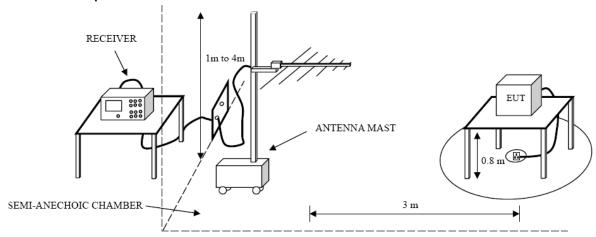
4.1.2. Test Limit

Radiated Disturbance Test Limit (Class B)

	Limit (dBμV/m)				
Frequency	Quasi-peak Level				
30MHz~230MHz	40				
230MHz~1000MHz	47				
Remark: 1. The lower limit shall apply at the transition frequency.					

2. The test distance is 3m.

4.2. Test Setup



4.3. Test Procedure

The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3m. The table was rotated 360 degrees to determine the position of the highest radiation.

The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.

The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range.

If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.



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4.4. Test Condition

Temperature	:	25 ℃
Relative Humidity	:	48 %
Pressure	:	1010 hPa
Test Power	:	DC 5V

4.5. Test Data

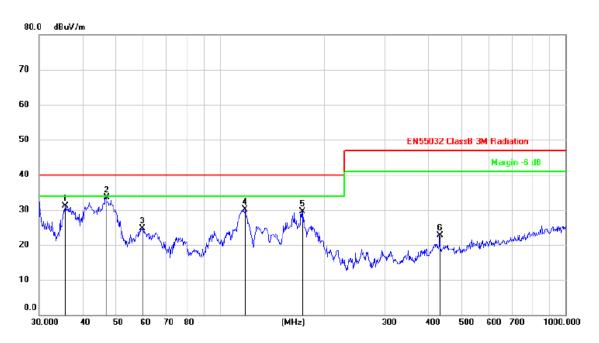
Please refer to the following pages.





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Operating Condition: Normal Test Specification: Horizontal

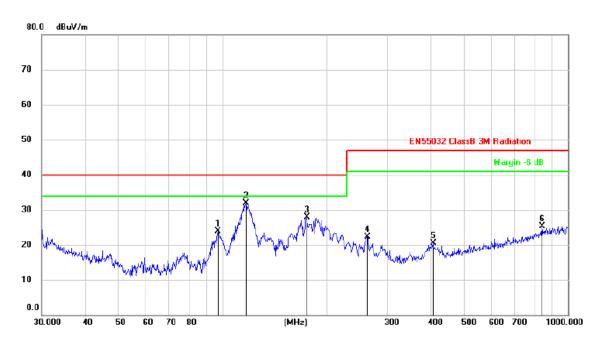


No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dBuV/m	dBuV/m	dBuV/m	dB	Detector
1		35.7490	46.18	-15.04	31.14	40.00	-8.86	QP
2	*	46.8303	46.21	-12.69	33.52	40.00	-6.48	QP
3		59.8588	38.80	-14.15	24.65	40.00	-15.35	QP
4		118.1860	45.90	-15.78	30.12	40.00	-9.88	QP
5		173.8135	45.61	-16.17	29.44	40.00	-10.56	QP
6		432.5457	30.81	-8.07	22.74	47.00	-24.26	QP



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Operating Condition: Normal Test Specification: Vertical



No	. Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dBuV/m	dBuV/m	dBuV/m	dB	Detector
1		97.1148	38.73	-14.92	23.81	40.00	-16.19	QP
2	*	117.3602	47.61	-15.64	31.97	40.00	-8.03	QP
3		175.6516	44.04	-16.06	27.98	40.00	-12.02	QP
4		262.8955	33.97	-11.66	22.31	47.00	-24.69	QP
5		407.5144	28.85	-8.43	20.42	47.00	-26.58	QP
6		842.1295	27.43	-2.16	25.27	47.00	-21.73	QP



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5. Electrostatic Discharge Immunity Test

5.1. Test Requirements

5.1.1. Test Standard

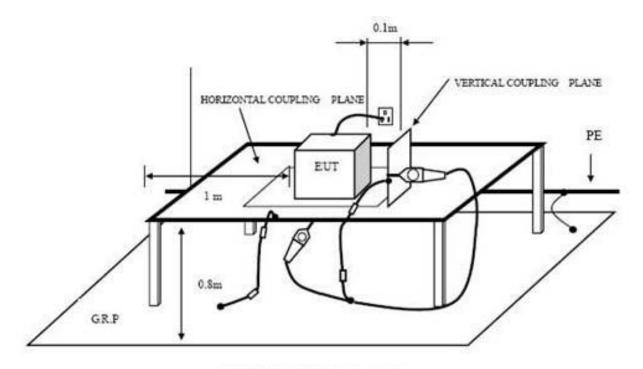
EN 55024: 2010 + A1: 2015 (EN 61000-4-2: 2009)

5.1.2. Test Level

Level	Test Voltage Contact Discharge (kV)	Test Voltage Air Discharge (kV)		
1	±2	±2		
2	±4	±4		
3	±6	±8		
4	±8	±15		
X	Special	Special		

5.1.3. Performance criterion: B

5.2. Test Setup



INDIRECT DISCHARGE SETUP



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5.3. Test Procedure

5.3.1. Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

5.3.2. Contact Discharge:

All the procedure shall be same as air discharge. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

5.3.3. Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

5.3.4. Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

5.4. Test Data

Please refer to the following pages.



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Electrostatic Discharge Test Result

EUT : USB Lanyard Cable M/N : RXD-888

Temperature : 22°C Humidity : 50%

Power supply: DC 5V Test Mode: Normal

Criterion: B

Air Discharge: $\pm 8kV$ Contact Discharge: $\pm 4kV$

For each point positive 10 times and negative 10 times discharge.

Location	Kind A-Air Discharge C-Contact Discharge	Result	
Nonconductive Enclosure	A	PASS	
Slot of the EUT	A	PASS	
USB Port	A	PASS	
LED Light	A	PASS	
НСР	С	PASS	
VCP of front	С	PASS	
VCP of rear	С	PASS	
VCP of left	С	PASS	
VCP of right	С	PASS	



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6. Radiated Electromagnetic Field Immunity Test

6.1. Test Requirements

6.1.1. Test Standard

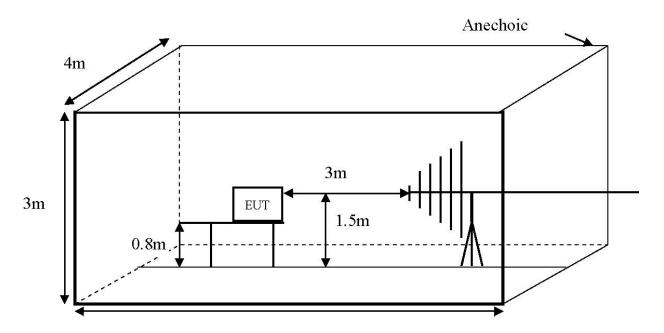
EN 55024: 2010 + A1: 2015 (EN 61000-4-3: 2006+A1: 2008+A2: 2010)

6.1.2. Test Level

Level	Field Strength V/m	
1	1	
2	3	
3	10	
Х	Special	

6.1.3. Performance criterion: A

6.2. Test Setup



6.3. Test Procedure

The EUT are placed on a table, which is 0.8 meter high above the ground. The EUT is set 3 meters away from the transmitting antenna, which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna is set on test. Each of the four sides of the EUT must be faced this transmitting antenna and measured individually.

In order to judge the EUT performance, a camera is used to monitor its screen.

All the scanning conditions are as following:



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Condition of Test	Remark	
Fielded strength	3V/m (Severity Level 2)	
Radiated signal	Modulated	
Scanning frequency	80-1000MHz	
Sweep time of radiated	0.0015 Decade/s	
Dwell time	1 Sec.	

6.4. Test Data

Please refer to the following pages.



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RF Field Strength Susceptibility Test Results

EUT : USB Lanyard Cable M/N : RXD-888

Temperature : 22°C Humidity : 50%

Power supply: DC 5V Test Mode: Normal

Criterion: A

Modulation: Unmodulated

Pulse: AM 1KHz 80%

	Frequency Range 1		Frequency Range 2	
	80~1000MHz			
	Horizontal	Vertical	Horizontal	Vertical
Front	PASS	PASS	/	/
Right	PASS	PASS	/	/
Rear	PASS	PASS	/	/
Left	PASS	PASS	/	/
Pomark:				

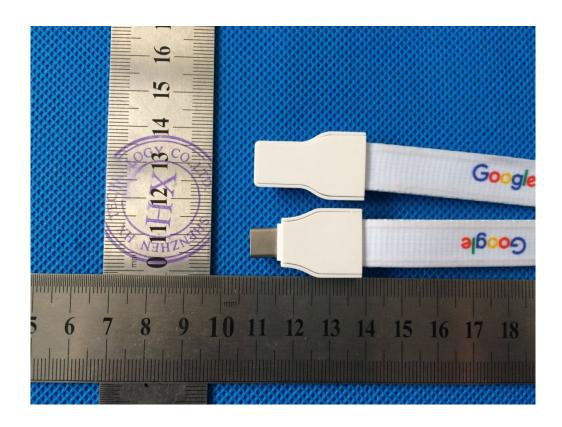
Remark:

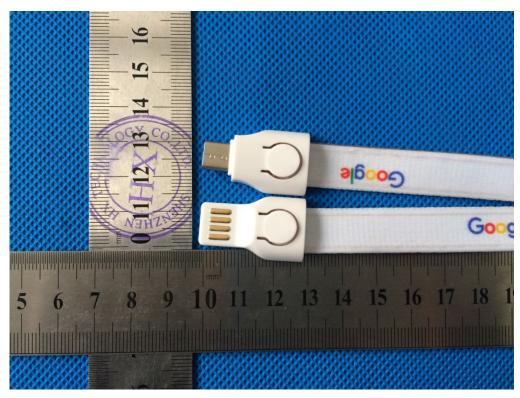




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7. Photographs - Constructional Details

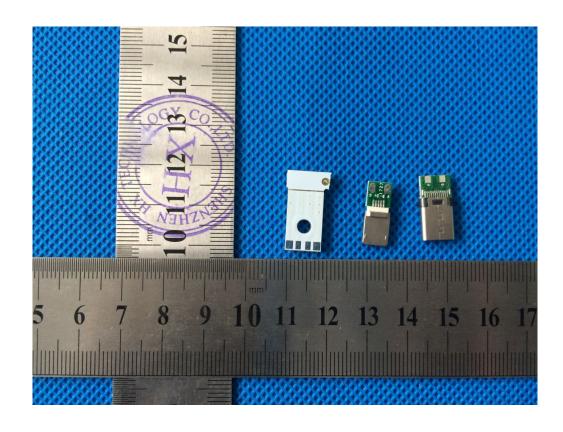








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END OF REPORT